## Notice of References Cited

Application/Control No. 10/694,015		Applicant(s)/Patent Under Reexamination LIU ET AL.		
Examiner	Art Unit			
Jossef Zilberman	4175	Page 1 of 1		

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,283,612 B1	09-2001	Hunter, Mark A.	362/240
*	В	US-6,371,637 B1	04-2002	Atchinson et al.	362/555
*	С	US-6,566,824 B2	05-2003	Panagotacos et al.	315/291
*	D	US-6,648,498 B1	11-2003	Tsao, Chia-Tsung	362/235
*	Е	US-2003/0224687 A1	12-2003	Fu et al.	445/22
*	F	US-2004/0260470 A1	12-2004	Rast, Rodger H.	701/300
*	G	US-2005/0044703 A1	03-2005	Liu et al.	029/876
*	Н	US-2005/0162850 A1	07-2005	Luk et al.	362/227
*	T	US-2005/0180162 A1	08-2005	Fan, Ben	362/555
*	J	US-2005/0286260 A1	12-2005	Liu et al.	362/551
*	к	US-7,135,034 B2	11-2006	Friedman et al.	607/88
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1357331 A2	10-2003	European Patent	LIN, YUAN	F21S 04/00
	0					
	Р					
	Q					
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

*	* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U	model de applicable. Palera, Tab Date, a demonte, politica e Forence, a cristica e agost	
Γ	v		
	w		
	×		

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.